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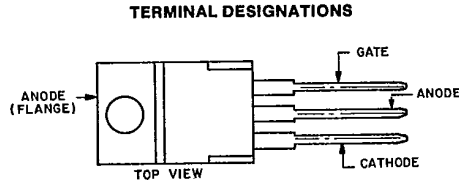
C122 Series

8-A Silicon Controlled Rectifiers

For Power Switching, Power Control

Features:

- High dv/dt capability
- Glass-passivated chip
- Shorted-emitter gate-cathode construction
- Low thermal resistance



JEDEC TO-220AB

The RCA-C122 series types are medium-power silicon controlled rectifiers designed for switching ac and dc currents. These devices can switch from the off-state to the on-state when both the anode and gate voltages are positive. Negative anode voltages make these devices revert to the blocking state regardless of gate-voltage polarity.

The TO-220AB package provides easy package mounting and low thermal resistance, allowing operation at high case temperatures and permitting reduced heat-sink size. These SCR's can be used in lighting and motorspeed controls and power-switching systems.

MAXIMUM RATINGS, Absolute-Maximum Values:

	C122F	C122A	C122B	C122C	C122D	C122E	C122M	
V_{RRM}, V_{DRM}	50	100	200	300	400	500	600	V
$I_{T(RMS)}$ ($T_C = 75^\circ C, \theta = 180^\circ$)	8							A
I_{TSM}								
For one full cycle of applied principal voltage								A
400-Hz	200							A
60-Hz	100							A
50-Hz	85							A
For more than one full cycle of applied principal voltage	See Fig. 3							
di/dt								
$V_D = V_{DRM}$ $I_{GT} = 80 \text{ mA}, t_r = 0.5 \mu s$	100							A/ μs
t^2								
$T_J = -65 \text{ to } 100^\circ C,$ $t = 1 \text{ to } 8.3 \text{ ms}$	40							A ² s
P_{GM}^* (for 10 μs max.)	16							W
$P_{G(AV)}^*$ (averaging time = 10 ms max.)	0.5							W
T_{sig}	-65 to +150							$^\circ C$
T_C	-65 to +100							$^\circ C$
T_T								
During soldering for 10 s maximum (terminal and case)	250							$^\circ C$

Δ These values do not apply if there is a positive gate signal. Gate must be open or negatively biased.
 • Any values of peak gate current or peak gate voltage which result in equal or lower power are permissible.

Silicon Controlled Rectifiers

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ELECTRICAL CHARACTERISTICS

At Maximum Ratings Unless Otherwise Specified and at Indicated Case Temperature (T_C)

CHARACTERISTIC	LIMITS			UNITS
	FOR ALL TYPES Except as Specified			
	Min.	Typ.	Max.	
I_{DOM} or I_{ROM} $V_D = V_{DROM}$ or $V_R = V_{RROM}$, $T_C = +100^\circ\text{C}$	-	0.1	0.5	mA
v_T $i_T = 16 \text{ A}$, $T_C = +25^\circ\text{C}$ For other values of i_T	-	1.45	1.83	V
I_{GT} $V_D = 12 \text{ V (DC)}$, $R_L = 30 \Omega$ $T_C = +25^\circ\text{C}$	-	10	15	mA
V_{GT} $V_D = 12 \text{ V (DC)}$, $R_L = 30 \Omega$ $T_C = +25^\circ\text{C}$	-	1.0	1.5	V
i_{HO} $T_C = +25^\circ\text{C}$	-	20	30	mA
dv/dt $V_D = V_{DROM}$ Exponential voltage rise $T_C = +100^\circ\text{C}$ (See Fig. 12)	10	100	-	V/ μs
t_{gt} $V_D = V_{DROM}$, $i_T = 4.5 \text{ A}$, $i_T = 2 \text{ A}$ $I_{GT} = 80 \text{ mA}$, $0.1 \mu\text{s}$ rise time $T_C = +25^\circ\text{C}$ (See Fig. 10)	-	1.6	2.5	μs
t_g $V_D = V_{DROM}$, $i_T = 2 \text{ A}$, $t_p = 50 \mu\text{s}$ $dv/dt = 200 \text{ V}/\mu\text{s}$, $di/dt = -10 \text{ A}/\mu\text{s}$ $I_{GT} = 200 \text{ mA}$ at t_{ON} , $T_C = +75^\circ\text{C}$ (See Fig. 13)	-	10	35	μs
$R_{\theta JC}$	-	-	1.8	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	-	-	75	$^\circ\text{C}/\text{W}$

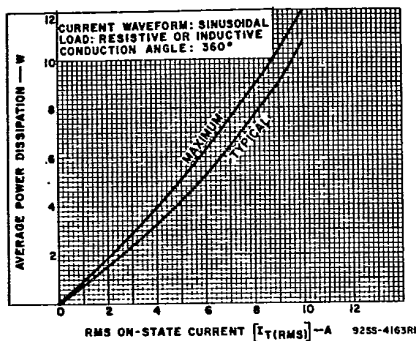


Fig. 1 — Power dissipation vs. on-state current.

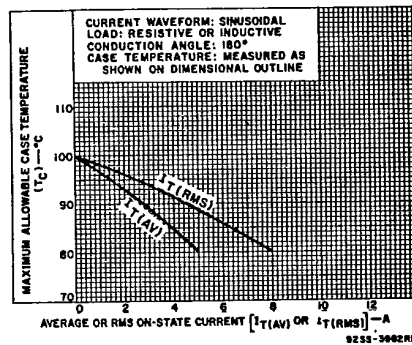


Fig. 2 — Maximum allowable case temperature vs. on-state current.

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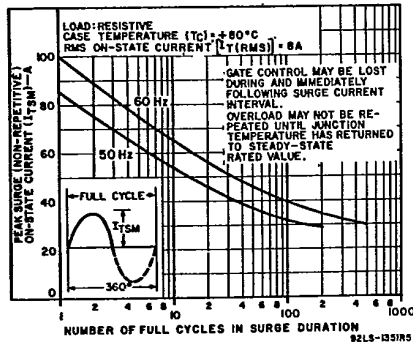


Fig. 3 — Allowable peak surge on-state current vs. surge duration.

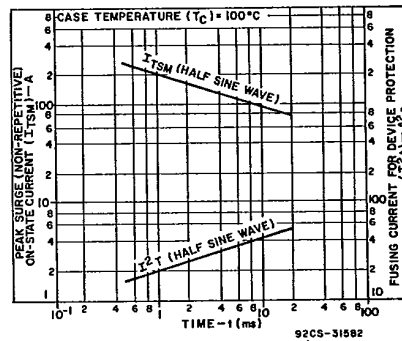


Fig. 4 — Peak surge on-state current and fusing current as a function of time.

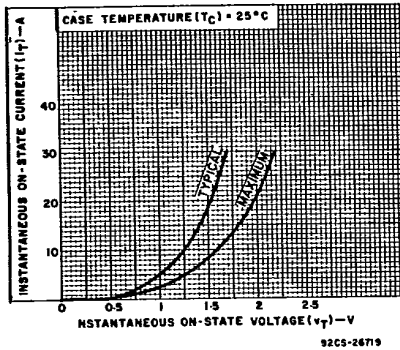


Fig. 5 — Instantaneous on-state current vs. on-state voltage.

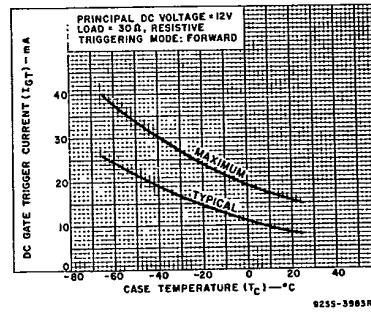


Fig. 6 — DC gate-trigger current vs. case temperature.

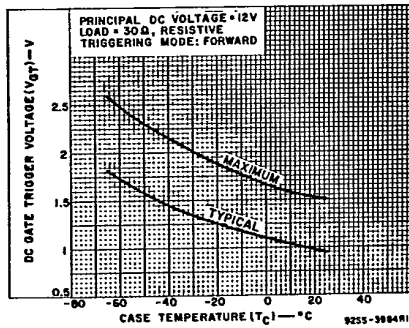


Fig. 7 — DC gate-trigger voltage vs. case temperature.

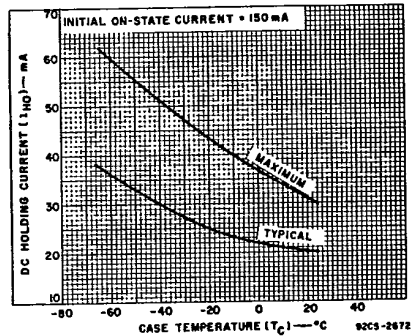


Fig. 8 — Holding current vs. case temperature.

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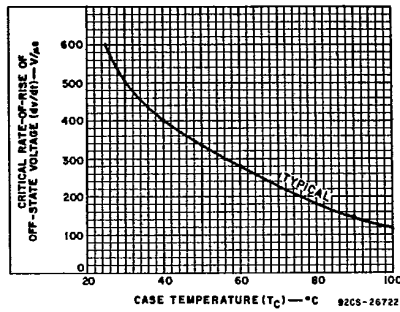


Fig. 9 — Critical rate of rise of off-state voltage vs. case temperature.

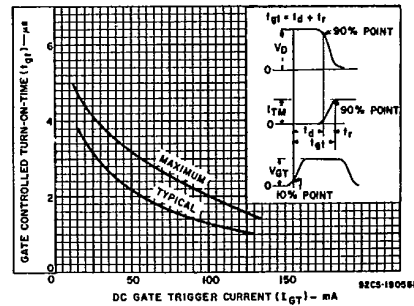


Fig. 10 — Gate-controlled turn-on time vs. gate trigger current.

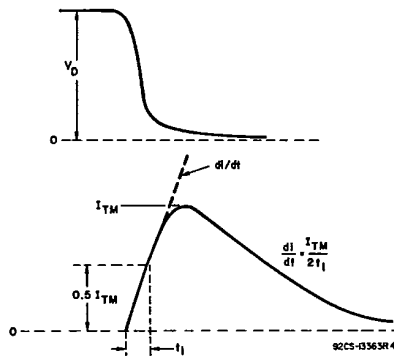


Fig. 11 — Rate of change of on-state current with time (defining dI/dt).

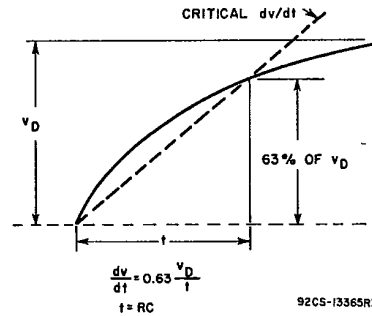


Fig. 12 — Rate of rise of off-state voltage with time (defining critical dV/dt).

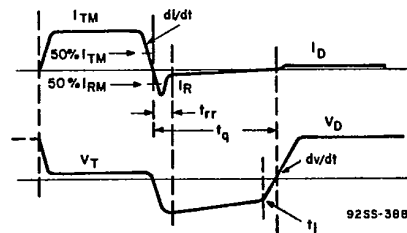


Fig. 13 — Relationship between instantaneous on-state current and voltage, showing reference points for measurement of circuit-commutated turn-off time (t_q).